

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,354	CHAN ET AL.	
Examiner	Art Unit	
Christopher D. Koharsk	3763	

SEARCHED					
Class	Subclass	Date	Examiner		
604	246	2/27/2006	CDK		
604	22	2/27/2006	CDK		
604	41	2/27/2006	CDK		
604	523	2/27/2006	CDK		
604	533	2/27/2006	CDK		
604	164.1	2/27/2006	CDK		
604	96.01	2/27/2006	CDK		
604	264	2/27/2006	CDK		
604	158	2/27/2006	CDK		
604	164.13	2/27/2006	CDK		
604	164.01	2/27/2006	CDK		
604	164.03	2/27/2006	CDK		
604	85	2/27/2006	CDK		
606	192, 198	5/21/2007	CDK		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
604	96.01	5/21/2007	CDK		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search	2/27/2006	CDK		
Inventor Search	2/27/2006	CDK		
PLUS Search	2/27/2006	CDK		
East Search Updated	7/13/2006	CDK		
East Search Updated	9/22/2006	CDK		
East Search Updated	11/19/2006	CDK		
East Search Updated	3/15/2007	CDK		
East search updated, interference searched	5/21/2007	CDK		